

**3M™ Tripolarized Wiremount Socket, 820 Series
3M™ 4-Wall, Tripolarized Header, 810 Series**

0.050" x 0.100" (1.27mm x 2.54mm) Pitch

Product Specification 78-5102-0074-0

Released: 2-22-2022



3M™ Tripolarized Wiremount Socket, 820 Series, 3M™ 4-Wall, Tripolarized Header, 810 Series

1. Scope

This document summarizes test methods, test conditions and product performance requirements for the 3M™ Tripolarized Wiremount Socket, 820 Series, 82XXX-600X-RB and 3M™ 4-Wall, Tripolarized Header, 810 Series, 81XXX-XX0X0X-RB. Listings of materials, finishes, test conditions, and test standards are included in this specification. In the event of conflict between this specification and any documents listed below, the listed documentation supersedes this specification.

2. 3M Documents

78-5100-0254-2 TS-0254, Technical Data Sheet for 3M™ Tripolarized Wiremount Socket, 820 Series
 78-5100-0253-4 TS-0253, Technical Data Sheet for 3M™ 4-Wall, Tripolarized Header, 810 Series
 34-7028-4354-0 3443-113 3M™ Locator Plate Instructions

3. Performance and Test Description

Unless otherwise specified, all tests shall be performed on 82100 sockets mated to 81100 headers using 3447/100, 3609/100, 3754/100, and 3756/100 cable at ambient environmental conditions per EIA-364. Unless otherwise specified, all values and limits are typical of those obtained by qualification testing of the subject product. All specifications are subject to revision and change without notice from 3M.

4. Requirements Overview

4.1 Ratings

Dielectric withstanding voltage: 500 VAC_{RMS} at sea level
 Current: (EIA-364-070A method 2, 30°C maximum temperature rise.)
 0.75 Amperes, all contacts powered
 2.00 Amperes, 4 contacts powered
 3.00 Amperes, 1 contact powered
 UL: 0.75A, 30V, 125°C
 CUL: 0.75A, 30V, 125°C
 Temperature: -55°C to +105°C
 Insulation resistance: >1 x10⁹Ω at 500 VDC
 Process Temperature (Header): 260°C
 Moisture Sensitivity Level (Header): 1

4.2 Materials

Socket

Insulation: Glass Filled PBT
 Cover Clip: Stainless Steel
 Strain Relief: Stainless Steel
 IDC Contact: Beryllium Copper Alloy

Header

Body Insulation: High Temperature LCP
 Latch Insulation: High Temperature LCP
 Pin Contact: Copper Alloy

4.3 Finishes

Plating: (socket and header)
 Nickel: 50 - 150 μ inches, ASTM B689-97, SAE AMS-QQ-N-290
 Gold - Wiping Area: 30 μ inches Average, MIL-G-45204 Type II, Grade C
 Tin - Socket IDC: Matte Sn, 100 - 300 μ inches
 Tin - Header Solder Tails: Matte Sn, 100 - 300 μ inches

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4.4 Cable Accomodation

General Accomodation:

30 AWG, 0.025" pitch, stranded or solid conductor, flat cable, PVC, TPE, FEP, PO insulation

3M™ Ribbon Cables:

3M™ Round Conductor Flat Cable, 3754 Series: PVC, round stranded conductor

3M™ Round Conductor Flat Cable, 3447 Series: PVC, round solid conductor

3M™ Round Conductor Flat Cable, 3756 Series: TPE, round stranded conductor

3M™ Round Conductor Flat Cable, 3749 Series: TPE, round solid conductor

3M™ Round Conductor Flat Cable, 3609 Series: FEP, round stranded conductor

3M™ Round Conductor Flat Cable, 3604 Series: FEP, round solid conductor

3M™ Round Conductor Flat Cable, HF447 Series: PO, Halogen Free, round solid conductor

3M™ Round Conductor Flat, Controlled Impedance Cable, 7700 Series: PO, shielded, round solid conductor

3M™ Jacketed and Shielded Ribbon Cables:

3M™ Pleated Foil Shielded Cable, 90101 Series: TPE/PVC, round solid conductor, flat jacketed

3M™ Pleated Foil Shielded Cable, 90111 Series: TPE/PVC, round solid conductor, flat jacketed

3M™ Pleated Foil Shielded Cable, 90201 Series: TPE/TPE, round solid conductor, flat jacketed

3M™ Pleated Foil Shielded Cable, 90202 Series: TPE/TPE, round stranded conductor, flat jacketed

3M™ Pleated Foil Shielded Cable, 90211 Series: TPE/TPE, round solid conductor, flat jacketed

3M™ Pleated Foil Shielded Cable, 93101 Series: TPE/PVC, round solid conductor, flat jacketed

4.5 Regulatory Compliance

For regulatory information about this product, visit 3M.com/regs or contact your 3M representative.

5. Electrical

| Description or parameter | Values & limits | Units | Requirement or conditions | Test Standard or method |
|---------------------------------|----------------------|--------------------|--|--|
| Dielectric withstanding voltage | 500 | VAC _{RMS} | Measured between adjacent and opposing contacts. No disruptive discharge during 1 minute duration. Sea level with 70% relative humidity. | EIA-364-20F Method A Test Cond I |
| Dielectric breakdown voltage | 1000 | VAC _{RMS} | Ramp assembled pair at 500V/s until electrical arc. Sea level with 70% relative humidity. Excludes cable. | EIA-364-20F Method A Test Cond I |
| Current rating | 3.00 | Amperes | 1 line driven. 30°C temp. rise. 20% derated. | EIA-364-70A Method 2 |
| | 2.00 | | 4 line driven. 30°C temp. rise. 20% derated. | |
| | 0.75 | | All line driven. 30°C temp. rise. 20% derated. | |
| Low level connection resistance | <10 | Milliohms | 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-23C |
| Insulation resistance | >1 x 10 ⁹ | Ohms | Measured between adjacent and opposing contacts. 500 VDC for 1 minute duration. | EIA-364-21F |

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6. Mechanical

| Description or parameter | Values & limits | Units | Requirement or conditions | Test Standard or method |
|--------------------------------|-----------------|---------------|---|---|
| Header pin retention / contact | >500 | gF | Average Force / pin required to remove pin from header body. | EIA-364-29B |
| Vibration | ≤10 | ns | Mated connectors shall exhibit no discontinuities greater than specified. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-28F Condition V, Level A, 1.5hrs |
| Mechanical Shock | ≤10 | ns | Mated connectors shall exhibit no discontinuities greater than specified. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-27C Table 1 Test Cond. A |
| Mating Force / contact | 1.12 max | N | Mated to a .015" square pin. No latches. (Insertion Force) | EIA-364-13E |
| Unmating Force / contact | 0.33 min | N | Mated to a .015" square pin. No latches. (Withdrawl Force) | EIA-364-13E |
| Latch Retention Force | > 130 | N | Retention force of 2 latches on header, mated to socket. Straight pull on cable. | N/A |
| Durability (Full) | 50 | Mating cycles | 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-09C |

7. Physical

| Description or parameter | Values & limits | Units | Requirement or conditions | Test standard or method |
|---|-------------------------|-------------|--|------------------------------|
| Visual | na | na | No defects such as deformation, blister, damage, crack, etc. | EIA-364-18A |
| Plating thickness Nickel Gold SN | 50-150 30 100-300 | Microinches | Average of random measurements from any 3 lots. | EIA-364-48 (A) |
| Header solderability, lead-free dip test | >95 | Percent | Coverage of solderable area. | EIA-364-52 (A) Category 3 |

8. Environmental

| Description or parameter | Values & limits | Units | Requirement or conditions | Test Standard or method |
|-------------------------------------|-----------------|--------------|--|-------------------------------------|
| Temperature Life (Thermal Aging) | 105 | degrees C | 1008 hours. No physical abnormalities . 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-17C Method A Condition 4 |
| Humidity Temperature Cycling | 10 | 24 hr cycles | 25-65 C / 90-98%RH with one -10 degree C subcycle. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-31F Method IV Fig 1 |
| Thermal Shock | 5 | cycles | -55 to +105 degrees C. No evidence of mechanical damage. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-32G Method A Test Cond. VII |
| Salt Spray | 5 | % NaCl | 48 hours. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing. | EIA-364-26C Test Cond. B |
| Moisture Sensitivity Level (Header) | 1 | MSL | 260 C Reflow. No defects such as deformation, blister, damage, crack, etc., must maintain dimensional stability. | J-STD-020E |

9. Test Sequence**9.1 Sequenced Tests****TEST FLOW**

| Test | Sequence Numbers for Test Group | | | | |
|--|---------------------------------|-----|-------|-------|-----|
| | A | B | C | D | E |
| Visual | 0, 8 | 0,4 | 0,6 | 0,6 | 0,6 |
| Low Level Connection Resistance (LLCR) | 1,3,5,7 | 1,3 | 1,3,5 | 1,3,5 | |
| Durability (Full) | 2 | | | 2 | 3 |
| Mechanical Shock | | | 2 | | |
| Vibration | | | 4 | | |
| Thermal Shock | 4 | | | | |
| Humidity Temperature Cycling | 6 | | | | |
| Temperature Life (Thermal Aging) | | 2 | | | |
| Salt Spray | | | | 4 | |
| Dielectric Withstand Voltage | | | | | 1,4 |
| Dielectric Breakdown Voltage | | | | | 7 |
| Insulation Resistance | | | | | 2,5 |
| Temperature Rise vs. Current | | | | | |

9.2 Independent Tests

1. Plating Thicknesses
2. Header Solderability
3. Header Moisture Sensitivity Level
4. Header Pin Retention
8. Mating Force / Contact
9. Unmating Force / Contact
10. Latch Retention Force

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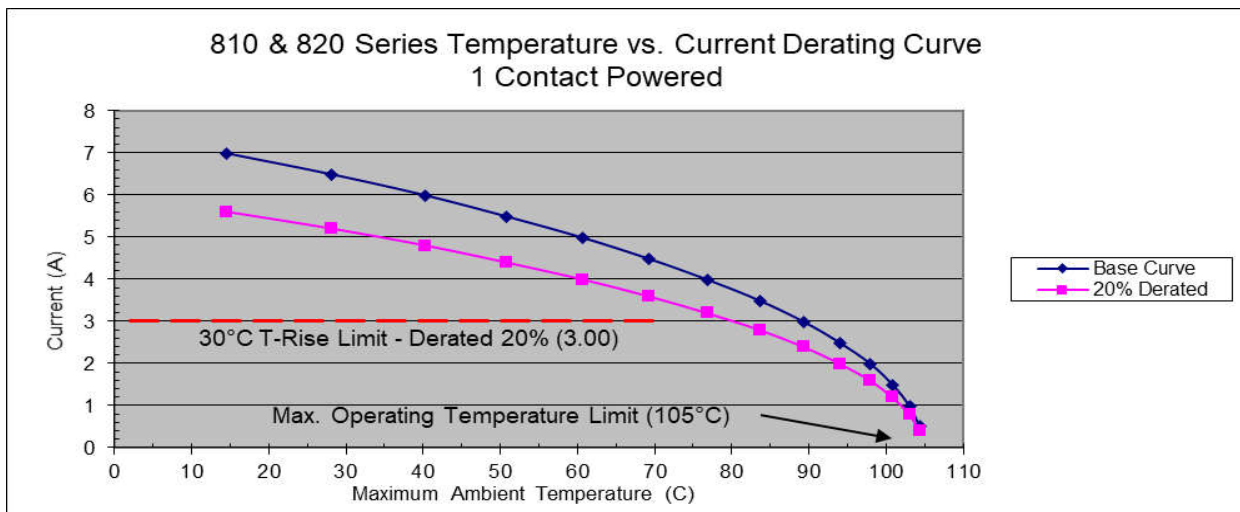
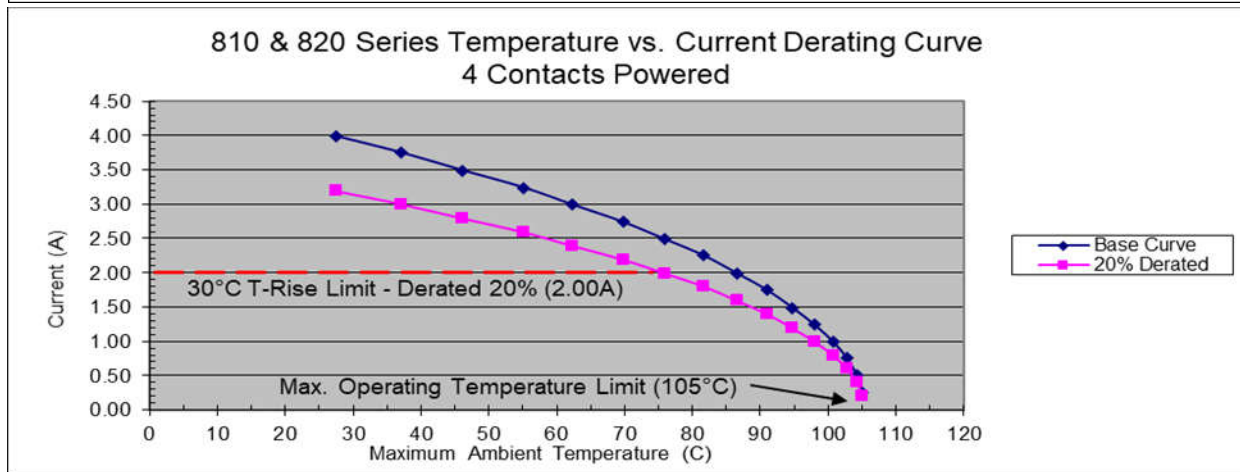
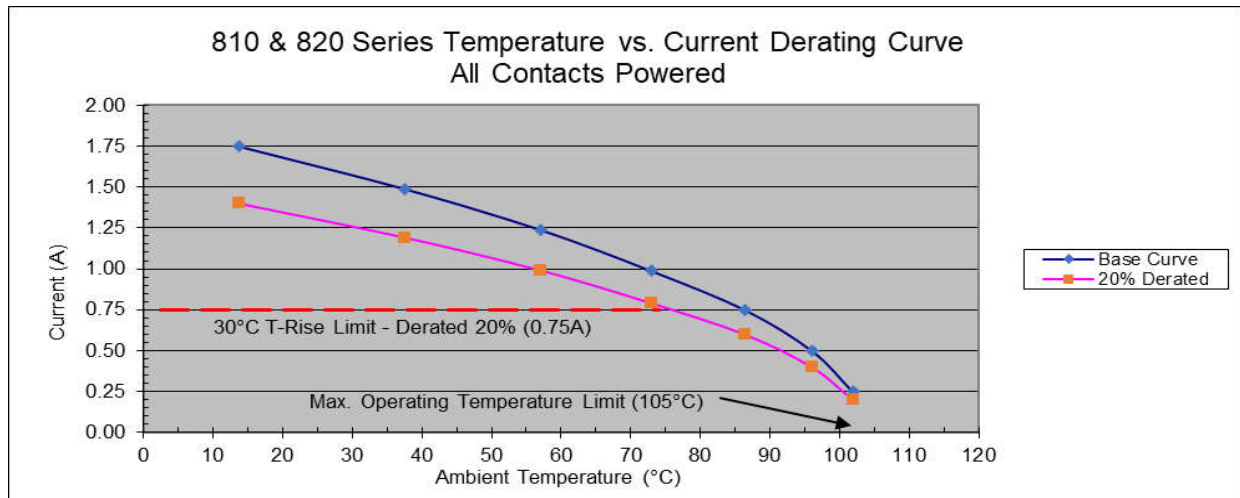
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10. Figures

10.1 Current Rating



11. Agency Listings**11.1 Underwriters Laboratories (UL)**

| Agency | File No. |
|--------|----------|
| UL | E68080 |
| CUL | E68080 |

Unless otherwise noted, references to industry specifications are intended to indicate substantial compliance to the material elements of the specification. Such references should not be construed as a guarantee of compliance to all

Regulatory: For regulatory information about this product, visit 3M.com/regs

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